

# Search Notes



Application/Control No.

10/525,035

Examiner

Rip A. Lee

Applicant(s)/Patent under Reexamination

JACOBSEN ET AL.

Art Unit

1713

## SEARCHED

Class	Subclass	Date	Examiner
526	160	03-23-2006	
526	161		
526	180		
502	103		
→ 502	104		
502	118		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
POST	03-23-2006	
PAM/edaw inv for search	03-23-2006	